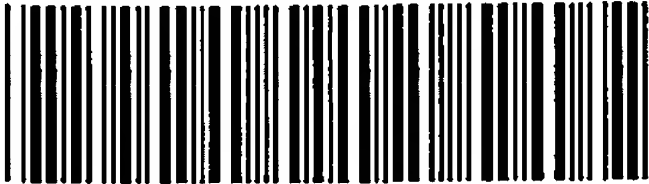


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/646,306	YU ET AL.	
	Examiner	Art Unit	
	David L. Lewis	2629	

SEARCHED			
Class	Subclass	Date	Examiner
345	55-100, 204-207	3/28/2007	DL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH keywords and subclass uspat, uspgpubs, usocr, epo, jpo, derwent, ibm; inventor name search	3/28/2007	DL